Notice of References Cited	Application/Control No. 10/812,884	Applicant(s)/Pater Reexamination KANAYAMA ET A		
	Examiner	Art Unit		
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0042006	03-2004	Chen et al.	356/301
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